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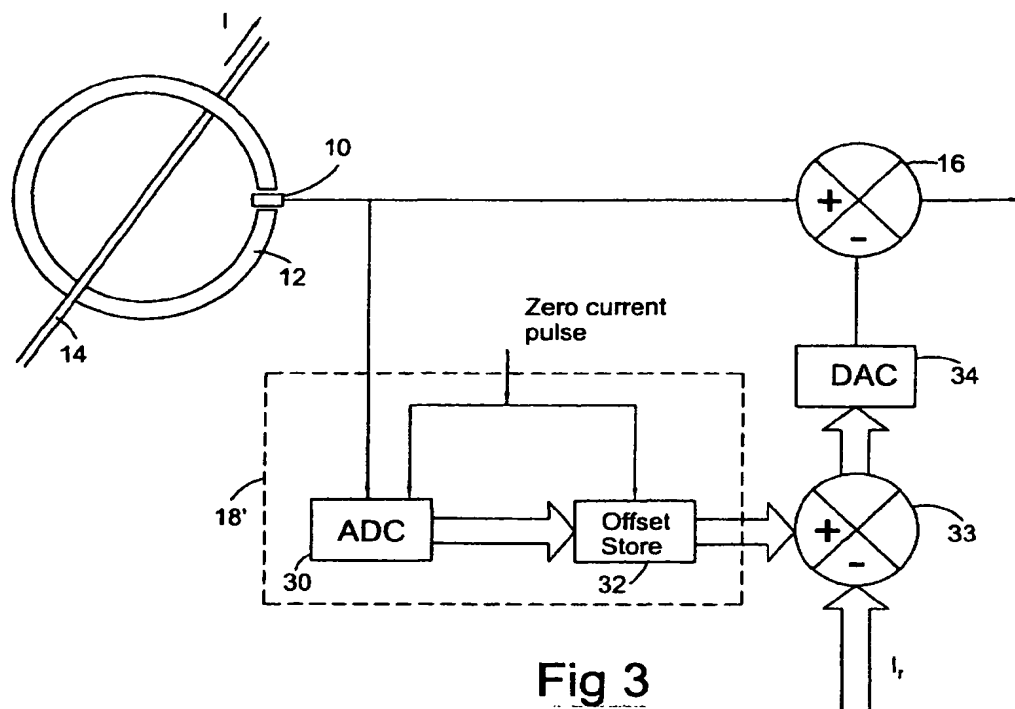
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(54) Transducer offset compensation

(57) A transducer circuit, particularly for monitoring current, compensates for offset in the transducer output by sampling the output periodically at a moment at which the output is known and storing the sampled value as an offset. The offset is compared with subsequent out-

puts from the transducer to provide a difference signal which is the compensated output of the transducer. When the calibrated output of the transducer is non-zero at the said moment, the non-zero value is added as a reference to the compensated value to correct the magnitude of the transducer output.



Description

This invention relates to offset compensation of the output of a transducer. The invention is particularly, though not exclusively, applicable to offset compensation in current measurement in the control of a switched reluctance machine.

Many electrical and electronic systems require transducers for converting a parameter into an electrical signal. For example, electric motors and generators require some means of monitoring current for a variety of well-recognised reasons, such as measurement, control and equipment protection. A simple technique for doing this is to derive a signal indicative of the current from the voltage dropped across a series-connected resistor in accordance with Ohm's law. This is a simple technique, but it has various drawbacks. Firstly, the resistor will have a non-zero temperature coefficient of resistance. It generates heat by virtue of the current flowing through it, which will distort the reading when it is used at a temperature other than that at which it is calibrated, due to its non-zero temperature coefficient of resistance. Secondly, the resistor must be connected directly in the circuit to be monitored. This alone makes resistance current monitoring impracticable in, for example, power circuits in which the current to be monitored is in a circuit at a high potential with respect to the circuit to which the monitored current signal is to be relayed. Thirdly, connecting the resistor in the monitored circuit may distort the operation of the circuit itself to an unacceptable degree.

The problem in relatively high potential circuits has been addressed by electrically isolating the circuit being monitored from the monitoring circuit itself. However, the need for isolation raises the further problem that the potential across the isolation barrier may change very rapidly. A typical example of this is in semiconductor switching circuits in which rapid changes in voltage in the monitored circuit occur as a result of switching. The large rate of change of voltage with respect to time (dV/dt) in the monitored circuit can cause capacitive current flow, induced across the isolation boundary, creating a further opportunity for corruption of the transducer output signal.

Current transformers (CT's) are a form of transducer by which a measure of current in a conductor can be derived. They are electrically isolated from the conductor itself and they have found extensive use in the field of electrical power engineering as, for example, monitors in current regulation and protection systems.

A known CT relies on the substantial balance of magnetomotive force (MMF) between primary and secondary windings that would exist in a CT using a high permeability core. Ideally, a zero secondary circuit impedance ("burden") would mean that this balance condition would be achieved at zero core flux. In practice, however, the non-zero burden dictates that a voltage will be dropped across the secondary winding with the result

that the core flux will also be non-zero.

The core flux is proportional to the integral of the secondary voltage. In the case of an alternating waveform, the amplitude of the core flux will therefore be inversely proportional to the frequency of the monitored current. In addition, the finite permeability of a real core requires MMF to drive the flux around the core. Assuming a linear response of the magnetic material of the core, this MMF will be directly proportional to the flux. As the core flux increases, a larger MMF will be needed to support it. Thus, with decreasing frequency the CT core absorbs an increasing proportion of the primary MMF. Therefore, the secondary MMF and the output current must fall.

It has been considered that this fall-off in the lower frequency response of a CT represents an operating limit on their usefulness. A low frequency CT means both a large core and a low secondary impedance to offer a flat frequency response over a specified working frequency range. In the limit, known CT's cannot operate at do (zero frequency) because of the non-zero secondary circuit resistance which is present in practice.

To address the problem of measuring current at low frequencies and at dc, current measuring devices have been developed that rely on the Hall effect. These are responsive to the strength of the magnetic field created by the current to be monitored. They are also often referred to in the art as "current transformers" although transformer principles are not involved.

A known current transducer based on the Hall effect uses a Hall-effect device arranged in an air gap in an otherwise toroidal core. The conductor carrying the current to be monitored is arranged to pass through the central aperture of the toroid. The Hall-effect device in the gap measures directly the flux resulting from the introduction of MMF in the core due to the current in the conductor.

While the device is relatively simply constructed, it has some disadvantages. Firstly, the response of the core material is not linear in practice. Secondly, the Hall-effect device also has a non-linear response and displays characteristics which introduce a static offset error into measurements. Furthermore, the small amplitude of the Hall voltage at the output of the device requires relatively large gain amplification which may render the monitoring circuit as a whole unacceptably prone to noise.

In general, the open-loop Hall-effect element tends to exhibit inconsistency in its output offset characteristics. That is, the output can be expressed as $(k \cdot I) + c$, where c is a non-constant offset term. The value of c may vary significantly from transducer to transducer, and may also vary with time, temperature, supply voltage and other factors. This can be a significant deterrent to using what would otherwise be an attractive, low-cost solution. For example, one manufacturer offers a range of current sensors based on their Hall-effect device, but the output offset voltage of their low-cost unit varies by

$\pm 10\%$ initially, is proportional to supply voltage and exhibits a temperature coefficient of $\pm 0.05\%$ per Kelvin. The initial offset can be trimmed out, but the temperature and supply-dependent offset variations may be less easy to deal with.

Feedback has been used in conjunction with a CT and a Hall-effect element. In this arrangement the problem of the secondary voltage in a CT is addressed by controlling a secondary current with an amplifier having an input which is a negative feedback signal from the Hall-effect element proportional to core flux. The secondary MMF is then independent of burden voltage and can be made to follow the MMF due to the current in the conductor closely by adjusting the product of the gain of the feedback amplifier and core permeability. With very large amplifier gain, the balance between the primary and secondary MMF's is determined only by the offset null of the Hall-effect element. Core linearity becomes largely irrelevant because the feedback action is always such as to maintain zero flux and thus to balance the MMF's. The ratio of primary to secondary current is, therefore, determined by the transformer turns ratio only.

Such transducers of the "flux-nulling" Hall-effect type have been popular in the electric machine control field (for example on switched reluctance motors and generators) because of their dc response, wide bandwidth and small size. An example of the flux-nulling sensor is one manufactured by LEM s.a. of Geneva, Switzerland. These sensors are non-invasive and electrically isolated from the monitored current. However, they are relatively expensive because they need an accurately zeroed Hall-effect element and fast responding amplifiers.

It is an object of the present invention to provide offset compensation for a transducer or a transducer circuit that is both inexpensive and does not require the complexity of the closed loop solutions referred to above.

According to the invention there is provided a transducer circuit comprising a transducer operable to produce an electrical transducer output signal indicative of the magnitude of a monitored parameter, sampling means for sampling the transducer output signal at a moment corresponding to a known value of the parameter, the sampling means providing an offset signal which is equivalent to the transducer signal at the said moment, and a differencer arranged to receive a subsequent transducer output signal and the offset signal and to produce a compensated output which is the difference between the subsequent transducer output and at least the offset signal.

The invention requires knowledge of the moment at which the monitored magnitude of the parameter will be at a known value, or knowledge of the value of the parameter at a known moment. The compensation applied takes account of any deviation in the output from the transducer with respect to the known value of the parameter and adjusts the transducer output automatical-

ly.

The invention is particularly useful in situations in which the known value of the parameter is zero (typically zero current for zero output from an ideal Hall-effect element). However, adjustment for non-zero outputs from the transducer corresponding to the known value can be effected by including an adder in the circuit which is arranged in relation to the differencer such that a reference signal corresponding to the said known value of the parameter is added to the compensated output.

Preferably, the sampling means comprise a sample and hold circuit. This is desirably a combination of a switch gating the output of the transducer to a storage capacitor. The output of the transducer is supplied to the capacitor to store the transducer output signal at the said moment.

Alternatively, the sampling means may include an analogue to digital converter (ADC) which is operable, in response to an actuating signal at the said moment, to derive the offset signal in the form of a digital word from the transducer signal. In this digital implementation of the invention it is preferable that the digital word is stored in a digital word store which supplies the digital word to the differencer.

In the case of the offset compensation by deriving an offset compensation signal from a non-zero output of the transducer, the adder may be a digital adder to which the reference signal is applied in digital form. The output of the adder may be supplied to a digital-to-analogue converter (DAC), providing an analogue signal indicative of the addition of the offset digital word and the reference digital word. This may then be applied to the differencer together with the offset compensation signal. In an alternative form, the differencer is a digital differencer which is operable to derive a digital form of compensated output.

The invention extends to a method of compensating for offset in the output of an electrical transducer producing an electrical transducer signal in response to a monitored parameter, the method comprising: sampling the transducer output signal at a moment corresponding to a known value of the parameter; and taking the difference between a subsequent transducer output signal and the sample transducer output signal to produce a compensated output.

The method may include adding a reference signal to the compensated output that corresponds to the correct transducer output for the said known value of the parameter at the said moment. This is particularly useful in those cases where the known value of the parameter is non-zero.

The invention also extends, in a particular form, to a switched reluctance drive system comprising a switched reluctance machine having a rotor and a stator and at least one stator winding, switch means connected with the stator winding and being actuatable to control the energy in the winding, and a controller operably connected to actuate the switch means, the controller

comprising timing means from which timing signals are derived for actuating the switch means, and a transducer circuit arranged to monitor the current in the winding which current has a known value during a recurring interval, the transducer circuit comprising a current transducer responsive to current in the winding to produce an electrical transducer output signal indicative of the monitored current, sampling means for sampling the transducer signal at a moment coincident with the known current, the sampling means providing an offset signal which is equivalent to the transducer signal at the said moment, a differencer arranged to receive a subsequent transducer output signal and the offset signal and to produce a compensated output which is the difference between the subsequent transducer output signal and at least the offset signal.

Preferably, in switched reluctance machine control, a cyclically recurring interval of zero-current can be used as the known current. Particular advantage of this zero-current interval is taken in the invention because it allows regular offset compensation without recourse to a reference signal input by sampling the output from the current transducer during the zero-current interval.

Preferably, the transducer includes a Hall-effect element. Preferably, a simple circuit can be used including the Hall-effect element, or any other transducer connected in an open-loop arrangement.

The invention can be put into practice in various ways some of which will now be described by way of example with reference to the accompanying drawings, in which:

Figure 1 is a schematic circuit diagram of a first embodiment of the invention;

Figure 2 is a waveform diagram illustrating winding current in the windings of the switched reluctance machine.

Figure 3 is a schematic circuit diagram of a second embodiment of the invention; and

Figure 4 is a schematic diagram of a switched reluctance drive system.

A current sensor is shown in Figure 1 comprising a Hall-effect element 10 which is arranged in the air gap of a ferromagnetic toroidal ring 12. The ring 12 embraces a conductor 14 carrying the current I which is the parameter to be monitored in this embodiment.

The output of the Hall-effect element 10 is described above as $(k \cdot I) + c$, where c is a non-constant offset term. This output is connected to the non-inverting input of a differencing circuit 16. In parallel with this, the output of the Hall-effect element is also connected with a sample and hold circuit 18 comprising a first buffer amplifier 20, a sampling switch 22 and a second buffer amplifier 24 all connected in series and forming a parallel

connection of the Hall-effect element output to the inverting input of the differencing circuit 16. A holding capacitor 26 is connected between the sampling switch 22 and the second buffer amplifier 24 to ground. A third input I_r to a non-inverting input of the differencing circuit 16 is a reference signal corresponding to the calibrated output of the transducer indicative of the known current at a predetermined moment.

Figure 1 represents an analogue implementation of the invention. By closing the switch 22 momentarily, but for sufficient time to charge the capacitor 26, the sample and hold circuit 18 is effectively updated with the output from the Hall-effect element. Considering, first of all, that the output of the Hall-effect element for zero current at a known moment at which the sample is taken will comprise only the offset term c , the difference between the updated offset signal stored in the sample and hold circuit 18 and any subsequent output from the transducer is automatically compensated for drift or offset present in the output.

In the case of a non-zero output from the transducer corresponding to the known value at the particular moment, the calibrated output of the transducer as it should be without drift is applied as the reference signal I_r to be added to the result of the difference between the subsequent transducer output and the stored offset signal.

The scheme uses prior knowledge of the current to be measured at a particular moment to derive the offset signal from the actual output of the transducer. This allows any offset to be eliminated.

Figure 2(a) shows a typical phase winding current waveform (I) in a switched reluctance motor, where the invention can be applied to advantage. By virtue of constraints on the energisation timing (as is usual for a switched reluctance machine), the phase current I at the end of each electrical cycle is known to be zero when the motor is run in a discontinuous phase current mode of operation. At these known zero current points, the switch 22 is momentarily closed by means of an actuation signal pulse 28, thus storing the offset as a voltage (corresponding to zero current) in the capacitor 26. The actuation pulse 28 is shown in Figure 2(b). Since, in a typical switched reluctance system, the time T_0 is not necessarily known to the central system but T_1 (the instant at which the phase winding is re-energised) is known, it may be convenient to employ an actuation pulse 28', as shown in Figure 2(c), beginning at T_1 and ending a short time thereafter at T_2 . Since in a typical switched reluctance machine the period of the phase current cycle (i.e. $T_3 - T_0$) may be comparatively short (e.g. several milliseconds), the error introduced by opening the sample-and-hold switch 22 after the interval of zero current (i.e. T_0 to T_1) will be small.

The offset voltage is subtracted from the subsequent sensor output, so giving a more accurate current measurement compensated for offset. Providing the offset is sampled often enough, offset drift due to temperature and supply voltage variations will be largely can-

celled. Only the variation over a sample interval will remain. In the case of a switched reluctance machine, the current at the moment in question is known to be zero. Therefore, this embodiment of the invention does not require a bias input to the comparator indicative of the reference current I_r at the predetermined moment.

In Figure 3 a partly digital implementation of the invention is shown. The output from the Hall-effect element 10 is applied to a digital sample and hold circuit 18' comprising an analogue-to-digital converter (ADC) 30, the digital offset word being stored in an offset store 32. A digital version of the current reference word I_r representing the known current at the predetermined moment is subtracted from the offset word being stored in the store 32 in a digital subtractor. The difference between the offset word and the current reference word I_r represented by the output of the subtractor 33 is applied to a digital-to-analogue converter (DAC) 34 and the analogue output from the DAC 34 is applied to the inverting input to the analogue differencing circuit 16 where it is subtracted from the output of the Hall-effect element 10. As before, the output of the differencing circuit 16 is the offset adjusted (compensated) signal from the Hall-effect element 10 indicative of the monitored current. As with the fully analogue implementation of the invention, the sample and hold circuit 18' is caused to take a sample of the output of the Hall-effect element by means of the pulse 28 at the zero current points. This also loads the uncompensated word in the offset store 32.

The reference current I_r is generated digitally, then the difference between the word in the offset store and I_r is compared with the actual value in the analogue domain. This is likely to be necessary in some applications of switch-based electrical regulation where a software-based, fully digital, output may be too slow to implement the actual current control. In the context of a controller for a switched reluctance machine the phase winding current is part of the information fed back by which the controller effects its algorithmic control regime. Because the current feedback signal is driven by the difference between the output of the Hall-effect element 10 and the output of the DAC 34, adding the offset to the negated reference signal is equivalent to subtracting it from the Hall-effect element output. This arrangement offers the advantage that the sample and hold circuit and the adder 33 can be implemented entirely in software. It does require an analogue-to-digital converter, but this need only update the offset word relatively infrequently, so a high performance converter is not required in many applications. Many systems will have an ADC channel available for such purposes. Microcontrollers sometimes have built-in multichannel ADC's which could usefully be exploited in this invention.

The invention provides a low-cost monitoring system offering reduced offset drift. It also eliminates the need for initial trimming of the offset parameter for individual transducers, amplifiers etc. It makes use of intervals where the waveform is known to have a particular

value, and is therefore well-suited to use in a switched reluctance drive.

Figure 4 illustrates a switched reluctance drive in which the invention is implemented. It comprises a three-phase switched reluctance machine 36 which, for the sake of illustration, will be described in terms of a motor. The machine has phase windings A, B and C, a rotor R and stator S. In this much simplified illustration the machine 36 is controlled by a microprocessor-based controller 38 which receives feedback signals from a rotor position transducer 40, as is well known in the art, and phase current information from the Hall-effect element 10 on lines 42 and 44, respectively. According to known control strategies, the controller 38 generates firing signals on lines 46 which control the actuation of conventional switch apparatus 48 applying voltage to the phase windings from an electrical source V. In this embodiment the reference timing derived by the controller 38 to actuate the switches is also used to determine the moments at which the current in one of the phase windings will be zero. It is at this calculated moment that the offset reading, in either analogue or digital form, is taken by sampling the output of the Hall-effect element 10. The zero current moments will recur frequently as the rotor of the motor rotates, so allowing the offset value or word to be updated before significant drift from the last compensation was made.

It will be clear to the person skilled in the art that this invention is applicable to any transducer that is subject to drift or other offset from a calibrated condition over time. The invention is particularly applicable to, for example, electrical machines in which a known value of the monitored parameter will recur regularly and, preferably, periodically according to a known cycle. However, it is equally applicable to other transducers measuring other parameters in which there is a need for output offset compensation. Accordingly, the principles of the present invention, which have been disclosed by way of the above examples and discussion, can be implemented using various circuit types and arrangements and can be applied in different ways. Those skilled in the art will readily recognise that these and various other modifications and changes may be made to the present invention without strictly following the exemplary application illustrated and described herein and without departing from the true spirit and scope of the present invention which is set forth in the following claims.

Claims

1. A transducer circuit comprising a transducer for producing an output signal indicative of the magnitude of a monitored parameter, sampling means for sampling the transducer output signal at a moment corresponding to a known value of the magnitude of the parameter, the sampling means being arranged to store the sampled output signal as an offset sig-

- nal, the circuit further comprising a differencer arranged to receive at least a subsequent transducer output signal and the offset signal and to produce a compensated output which is the difference between the subsequent transducer output signal and at least the offset signal. 5
2. A circuit as claimed in claim 1 in which the sampling means comprise a sample and hold circuit, the sample and hold circuit being operable to sample the transducer output signal at the said moment and to hold the sampled output as the offset signal. 10
 3. A circuit as claimed in claim 1 or 2, including an adder arranged to receive the output of the sampling means and a reference signal corresponding to a calibrated output of the transducer at the said moment and to produce an output in the form of a sum of the output of the sampling means and the reference signal, the differencer being arranged to receive the output of the adder and to produce the compensated output which is the difference between the subsequent transducer output signal and the said sum. 15 20 25
 4. A circuit as claimed in claim 2 or 3 in which the sampling means comprise a gating device and a storage capacitor, the gating device being operable at the said moment to enable the transducer output to be applied to the storage capacitor and stored therein as the offset signal. 30
 5. A circuit as claimed in claim 2 or 3 in which the sampling means comprise an analogue-to-digital converter (ADC) and a digital word store arranged to receive the output of the ADC, the ADC being operable, in response to an actuating signal, to convert the transducer output at the said moment into a digital word, the digital word being storable in the digital word store as the offset signal. 35 40
 6. A circuit as claimed in claim 5, when dependent on claim 3, in which the adder is arranged to sum the offset word and the reference signal in the form of a reference word, the circuit further including a digital-to-analogue converter (DAC) arranged to convert the said sum into an analogue sum and to transmit the analogue sum to the differencer. 45
 7. A circuit as claimed in any preceding claim in which the transducer is a current transducer, for example including a Hall-effect element. 50
 8. A electrical machine drive system comprising an electrical machine, a machine controller and a transducer for producing an output indicative of the magnitude of a monitored parameter of the machine, the controller including sampling means for sampling the transducer output signal at a moment corresponding to a known value of the magnitude of the parameter, the sampling means being arranged to store the sampled output signal as an offset signal, the controller further comprising a first differencer arranged to receive at least a subsequent transducer output signal and the offset signal and to produce a compensated output which is the first difference between the subsequent transducer output signal and at least the offset signal. 55
 9. A system as claimed in claim 8 in which the sampling means comprise a sample and hold circuit, the sample and hold circuit being operable to sample the transducer output signal at the said moment and to hold the sampled output as the offset signal.
 10. A system as claimed in claim 8 or 9 including a second differencer arranged to receive the output of the sampling means and a reference signal corresponding to the transducer output signal at the said moment and to produce an output in the form of a second difference between the output of the sampling means and the reference signal, the first differencer being arranged to receive the output of the second differencer and to produce the compensated output which is the difference between the subsequent transducer output signal and the second difference.
 11. A system as claimed in claim 9 or 10 in which the sampling means comprise a gating device and a storage capacitor, the gating device being operable at the said moment to enable the transducer output to be applied to the storage capacitor and stored therein as the offset signal.
 12. A system as claimed in claim 9 or 10 in which the sampling means comprise an analogue-to-digital converter (ADC) and a digital word store arranged to receive the output of the ADC, the ADC being operable, in response to an actuating signal, to convert the transducer output at the said moment into a digital word, the digital word being storable in the digital word store as the offset signal.
 13. A system as claimed in claim 12, when dependent on claim 10, in which the adder is arranged to sum the offset word and the reference signal in the form of a reference word, the circuit further including a digital-to-analogue converter (DAC) arranged to convert the said sum into an analogue sum and to transmit the analogue sum to the differencer.
 14. A system as claimed in any of claims 8 to 13 in which the transducer is a current transducer arranged to monitor a current in the electrical machine.

15. A system as claimed in any of claims 8 to 14 in which the electrical machine is a switched reluctance machine operable according to a phase inductance cycle and the controller is operable to enable the sampling means during the phase inductance cycle of the electrical machine. 5
16. A system as claimed in claim 15 in which the transducer is arranged to monitor current to provide a signal indicative of the winding current, the said moment coinciding with an interval of substantially zero current in the winding. 10
17. A method of compensating for offset in the output of a transducer, the method comprising : 15
- sampling the output signal from the transducer at a moment corresponding to a known value of the magnitude of the parameter monitored by the transducer; 20
- storing the sampled output signal as an offset signal; and
- taking the difference between at least a subsequent transducer output signal and the offset signal to produce a compensated output which is the difference between the subsequent transducer output signal and at least the offset signal. 25
18. A method as claimed in claim 17 including gating the transducer output signal at the said moment and storing the said transducer output signal in a storage capacitor. 30
19. A method as claimed in claim 17, including subtracting a reference signal corresponding to the output of the transducer at the said moment from the offset signal to produce an output in the form of a second difference between the output of the sampling means and the reference signal, and taking the difference between the subsequent transducer output signal and the second difference. 35 40
20. A method as claimed in claim 17, including converting the output of the transducer at the said moment into a digital word and storing the digital word in a digital word store as an offset word. 45
21. A method as claimed in claim 20 in which the output is in the form of a digital word produced by subtracting the reference signal in the form of a reference word from the offset word, and the digital word is converted into an analogue signal, the difference taken being the difference between the subsequent transducer output signal and the analogue signal. 50 55
22. A method as claimed in any of claims 17 to 21 in which the parameter is current in an electrical machine.

23. A method as claimed in claim 22 in which the machine is a switched reluctance machine and the monitored current provides a signal indicative of winding current in the machine, the said moment coinciding with an interval of substantially zero current in the winding.

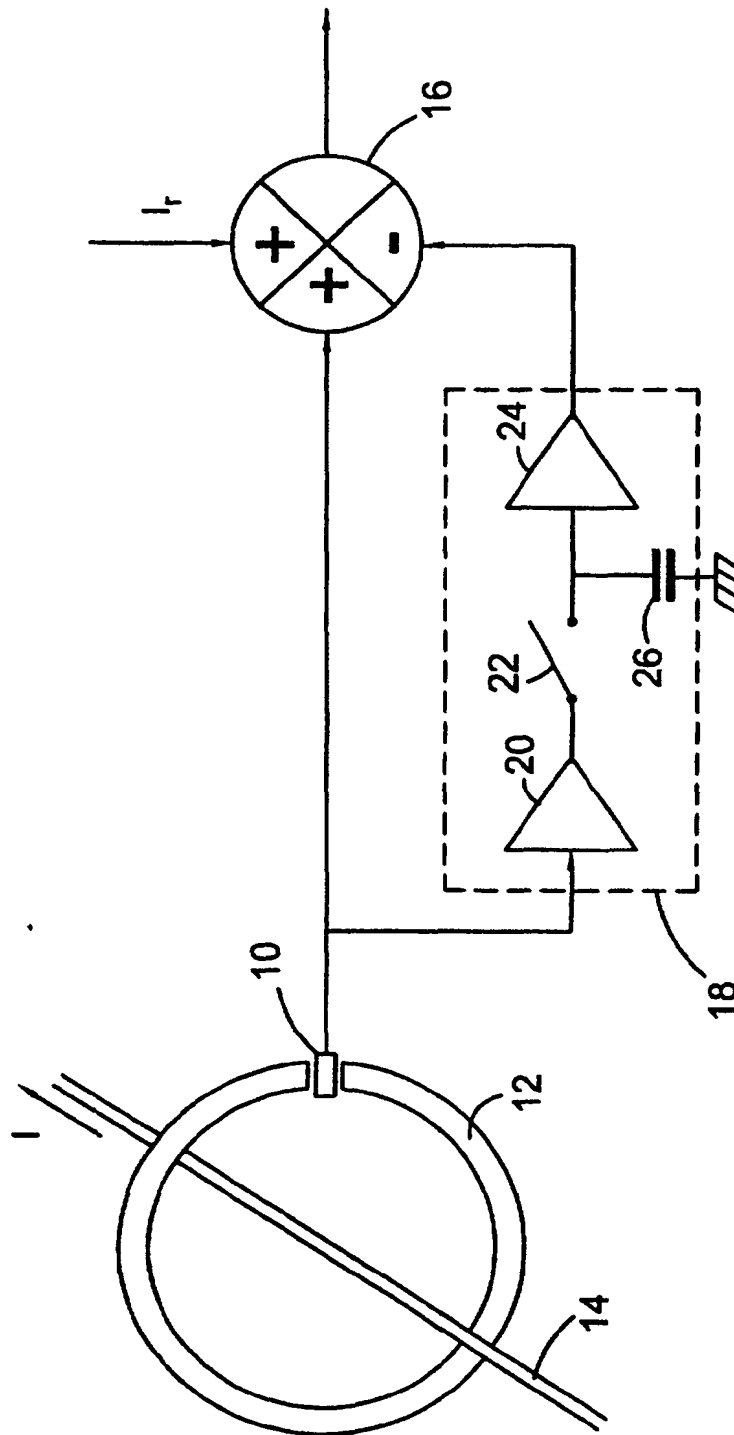
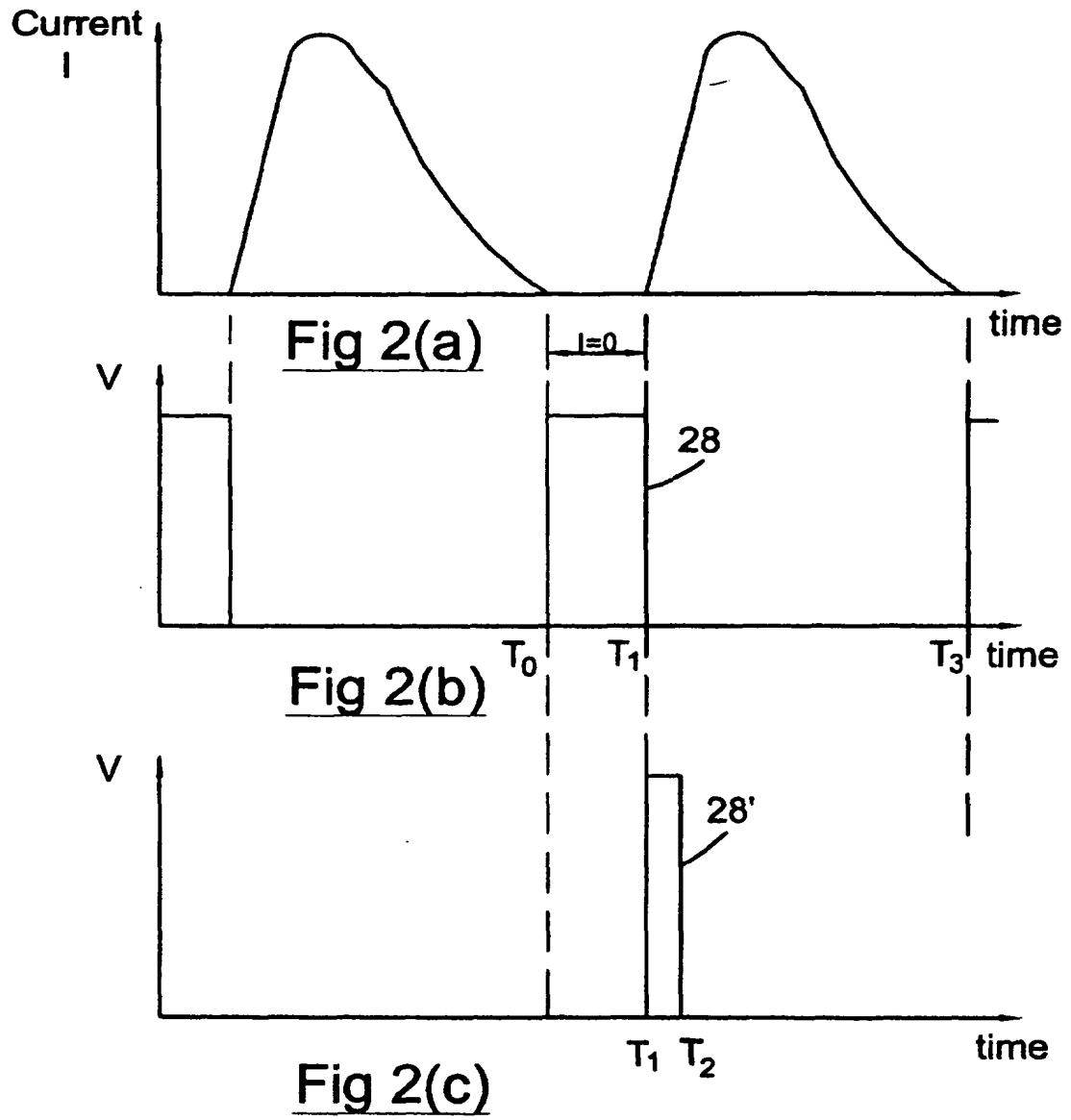


Fig 1



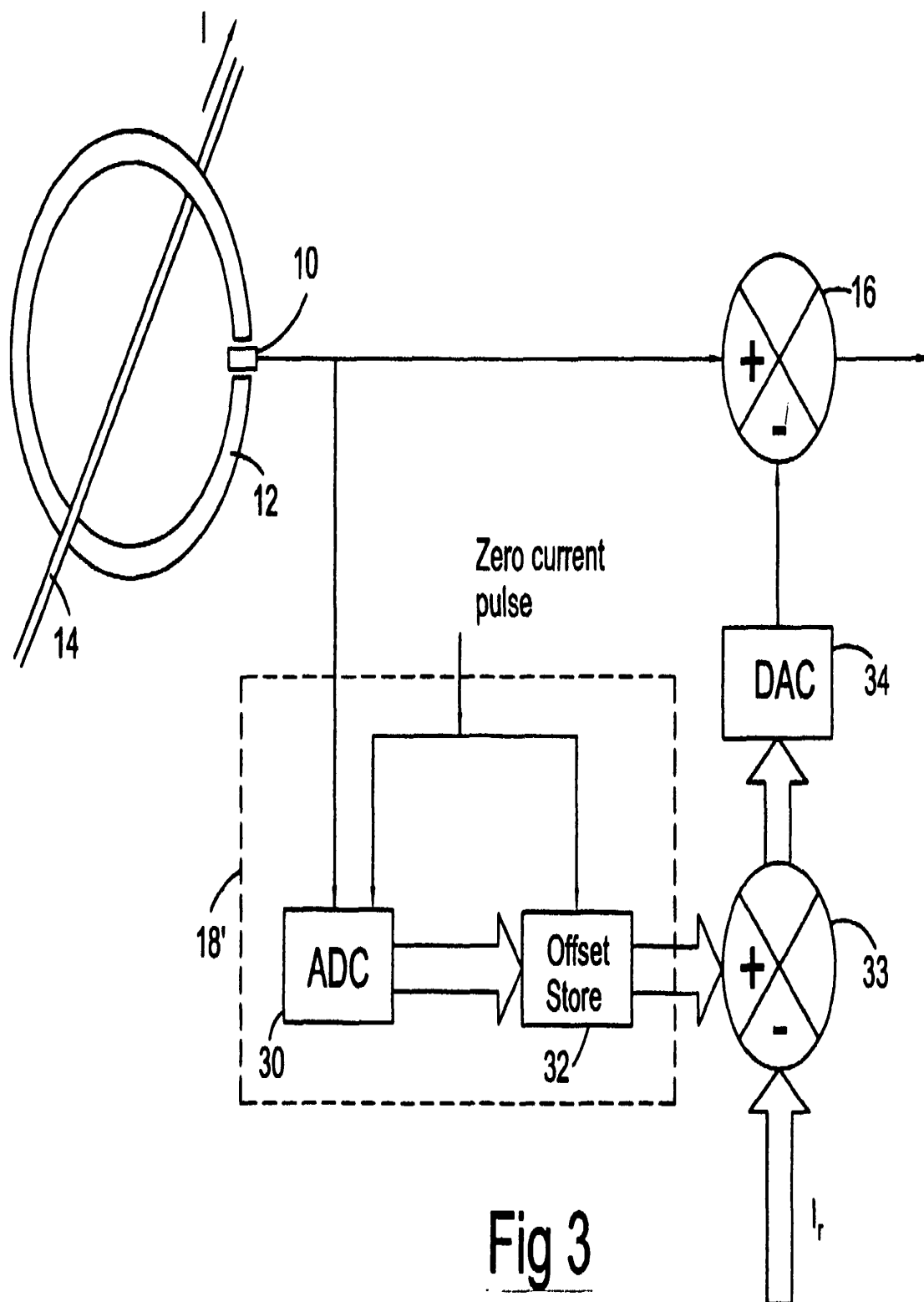
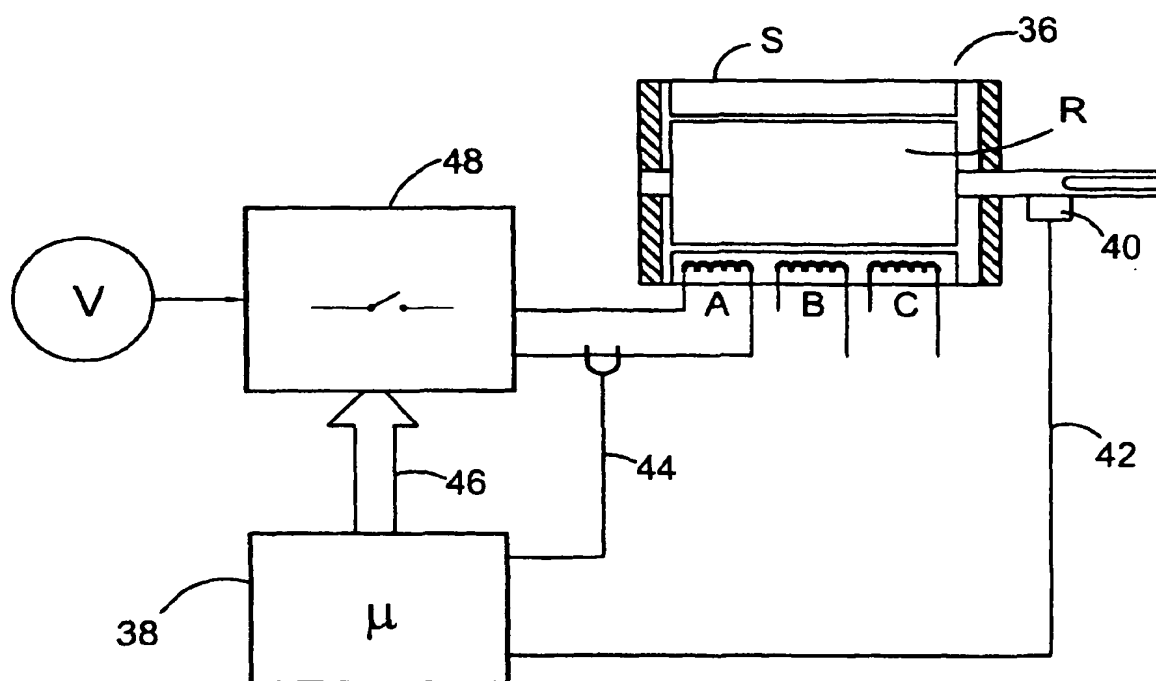


Fig 3

Fig 4



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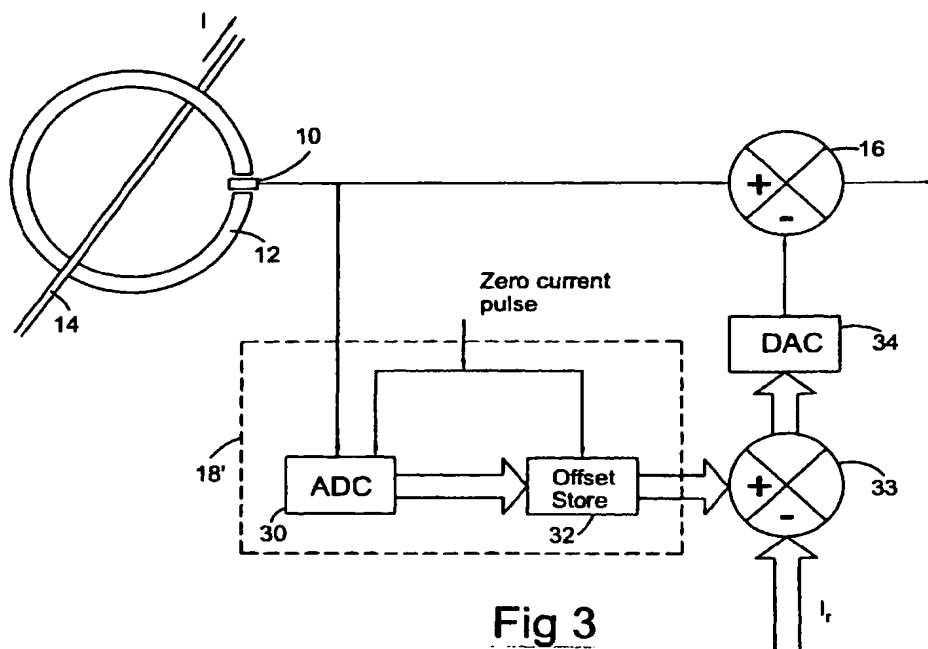


Fig 3



European Patent
Office

EUROPEAN SEARCH REPORT

Application Number
EP 98 30 3053

DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int.Cl.6)
X	PATENT ABSTRACTS OF JAPAN vol. 014, no. 376 (P-1092), 14 August 1990 (1990-08-14) -& JP 02 141673 A (MEIDENSHA CORP), 31 May 1990 (1990-05-31) * abstract; figures 1,3 *	1,2,4, 7-9,11, 14-18, 22,23	G01D18/00 G01R35/04
A	EP 0 360 348 A (PHILIPS PATENTVERWALTUNG ;PHILIPS NV (NL)) 28 March 1990 (1990-03-28) * page 3, last line - page 4, line 53 *	1,8,17	
A	PATENT ABSTRACTS OF JAPAN vol. 016, no. 504 (P-1439), 19 October 1992 (1992-10-19) & JP 04 184267 A (FUJI ELECTRIC CO LTD), 1 July 1992 (1992-07-01) * abstract *	1,8,17	
			TECHNICAL FIELDS SEARCHED (Int.Cl.6)
			G01R G01D
The present search report has been drawn up for all claims			
Place of search BERLIN		Date of completion of the search 20 September 1999	Examiner Hijazi, A
CATEGORY OF CITED DOCUMENTS X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document		T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document	

EPO FORM 1503 03.82 (Pd/C01)

**ANNEX TO THE EUROPEAN SEARCH REPORT
ON EUROPEAN PATENT APPLICATION NO.**

EP 98 30 3053

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20-09-1999

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
JP 02141673 A	31-05-1990	NONE	
EP 0360348 A	28-03-1990	DE 3832145 A	29-03-1990
		DE 58908265 D	06-10-1994
		JP 2136754 A	25-05-1990
		US 5121051 A	09-06-1992
JP 04184267 A	01-07-1992	NONE	

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For more details about this annex : see Official Journal of the European Patent Office, No. 12/82